

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/920,984 MIYANO ET AL.	
		Examiner	Art Unit	Page 1 of 1 Quynh H Nguyen

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,529,745	03-2003	Fukagawa et al.	455/562.1
	B	US-6,795,424	09-2004	Kapoor et al.	370/343
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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